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FDMS004N08C

N-Channel Shielded Gate PowerTrench® MOSFET 80 V, 126 A, 4.0 m Ω

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)}$ = 4.0 m Ω at V_{GS} = 10 V, I_D = 44 A
- Max $r_{DS(on)}$ = 10.4 m Ω at V_{GS} = 6 V, I_D = 22 A
- 50% Lower Qrr than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

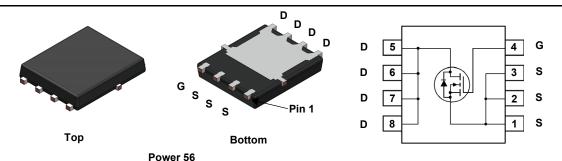
General Description This N-Channel MV MOSE

This N-Channel MV MOSFET is produced using ON Semiconductor's advanced PowerTrench® process that incorporates Shielded Gate technology. This process has been optimized to minimise on-state resistance and yet maintain superior switching performance with best in class soft body diode.

Applications

- Primary DC-DC MOSFET
- Synchronous Rectifier in DC-DC and AC-DC
- Motor Drive
- Solar





MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted.

Symbol	Parame	eter		Ratings	Units	
V_{DS}	Drain to Source Voltage			80	V	
V_{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T _C = 25 °C	(Note 5)	126		
	-Continuous	T _C = 100 °C	(Note 5)	80		
lD	-Continuous	T _A = 25 °C	(Note 1a)	18	Α	
	-Pulsed		(Note 4)	637		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	486	mJ	
Б	Power Dissipation	T _C = 25 °C		125	W	
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV	
T _J , T _{STG}	Operating and Storage Junction Tempera	ature Range		-55 to +150	°C	

Thermal Characteristics

$R_{ heta JC}$	Thermal Resistance, Junction to Case		1.0	°C/M
$R_{\theta,JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	50	°C/W

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS004N08C	FDMS004N08C	Power 56	13 "	12 mm	3000 units

Electrical Characteristics T_J = 25 $^{\circ}$ C unless otherwise noted.

Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Units
Off Chara	cteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25 °C		40		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 64 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.0	3.1	4.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		-8.3		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 44 A		3.4	4.0	
		V _{GS} = 6 V, I _D = 22 A		5.2	10.4	mΩ
		V _{GS} = 10 V, I _D = 44 A, T _J = 125 °C		5.8	6.5	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 44 A		98		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V - 40 V V - 0 V		3035	4250	pF
C _{oss}	Output Capacitance	V _{DS} = 40 V, V _{GS} = 0 V, f = 1 MHz		940	1315	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 WH12		27	40	pF
R_g	Gate Resistance		0.1	1.1	2.3	Ω

Switching Characteristics

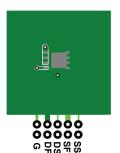
t _{d(on)}	Turn-On Delay Time		17	30	ns
t _r	Rise Time	V _{DD} = 40 V, I _D = 44 A,	6	12	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	25	40	ns
t _f	Fall Time		4	10	ns
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	39	55	nC
Q_g	Total Gate Charge	$V_{GS} = 0 \text{ V to 6 V}$ $V_{DD} = 40 \text{ V},$	25	34	nC
Q_{gs}	Gate to Source Charge	I _D = 44 A	13		nC
Q_{gd}	Gate to Drain "Miller" Charge		7		nC
Q _{oss}	Output Charge	V _{DD} = 40 V, V _{GS} = 0 V	55		nC
Q _{sync}	Total Gate Charge Sync.	V _{DS} = 0 V, I _D = 44 A	35		nC

Drain-Source Diode Characteristics

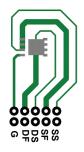
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.1 \text{ A}$ (Note 2)	0.7	1.2	V
	Source to Drain Diode 1 of ward voltage	$V_{GS} = 0 \text{ V}, I_{S} = 44 \text{ A}$ (Note 2)	0.8	1.3	v
t _{rr}	Reverse Recovery Time	I _F = 22 A, di/dt = 300 A/μs	26	41	ns
Q _{rr}	Reverse Recovery Charge	-1 _F - 22 A, αι/αι - 300 A/μs	48	76	nC
t _{rr}	Reverse Recovery Time	-I _F = 22 A, di/dt = 1000 A/μs	19	31	ns
Q_{rr}	Reverse Recovery Charge		108	174	nC

Notes:

1. R_{8JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{8CA} is determined by the user's board design.



50 °C/W when mounted on a 1 in² pad of 2 oz copper



125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.
 3. E_{AS} of 486 mJ is based on starting T_J = 25 °C; N-ch: L = 3 mH, I_{AS} = 18 A, V_{DD} = 80 V, V_{GS} =10 V. 100% test at L = 0.1 mH, I_{AS} = 57 A.
 4. Pulsed Id please refer to Fig 11 SOA graph for more details.
 5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

Typical Characteristics T_J = 25 °C unless otherwise noted.

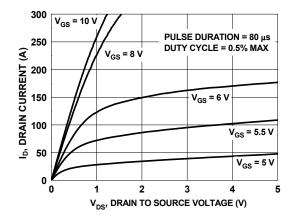


Figure 1. On Region Characteristics

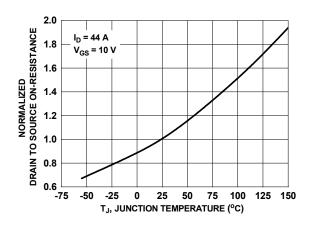


Figure 3. Normalized On Resistance vs. Junction Temperature

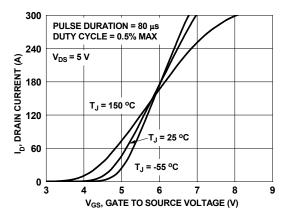


Figure 5. Transfer Characteristics

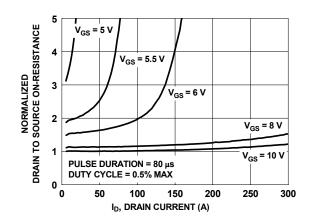


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

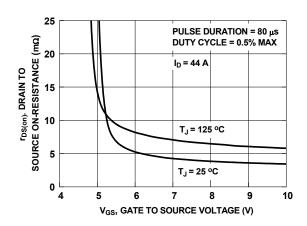


Figure 4. On-Resistance vs. Gate to Source Voltage

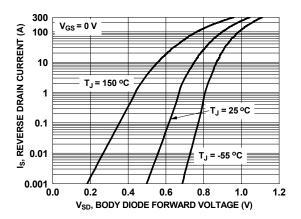


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted.

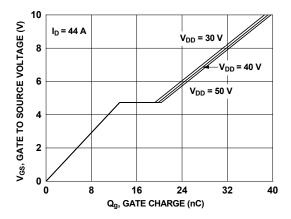


Figure 7. Gate Charge Characteristics

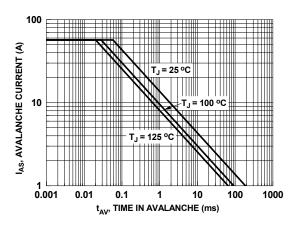


Figure 9. Unclamped Inductive Switching Capability

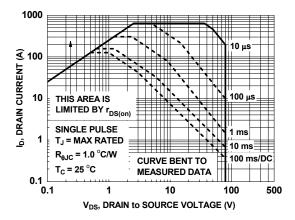


Figure 11. Forward Bias Safe Operating Area

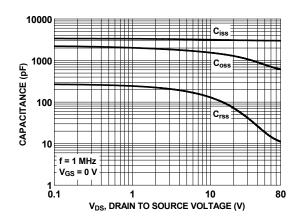


Figure 8. Capacitance vs. Drain to Source Voltage

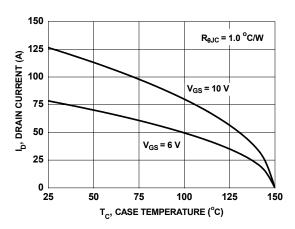


Figure 10. Maximum Continuous Drain Current vs Case Temperature

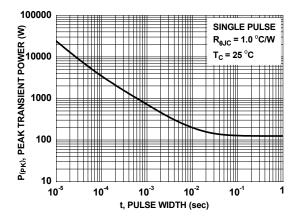


Figure 12. Single Pulse Maximum Power Dissipation



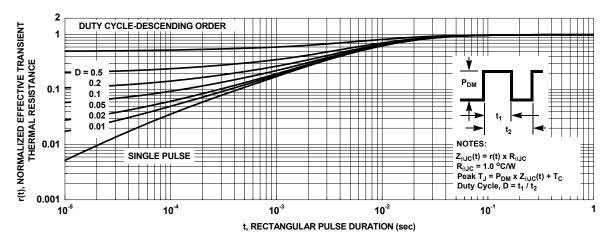
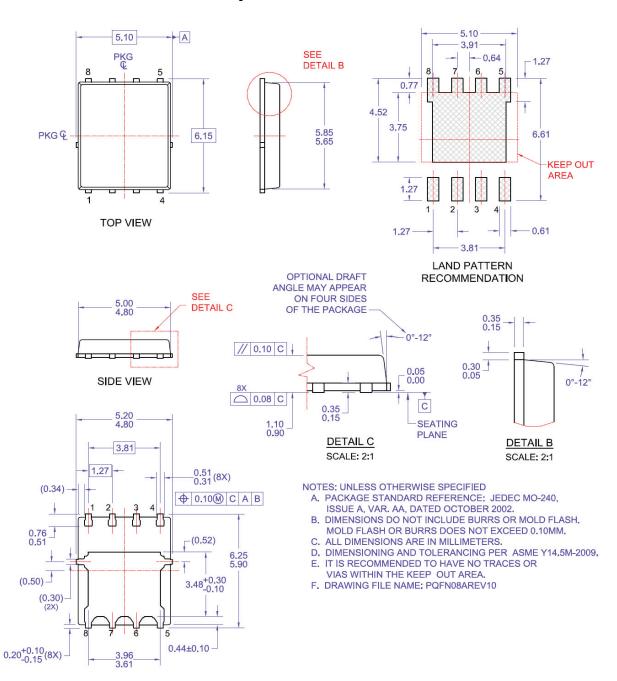


Figure 13. Junction-to-Case Transient Thermal Response Curve

Dimensional Outline and Pad Layout



BOTTOM VIEW

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